

10/070991

JC13 Rec'd PTO

14 MAR 2002

PTO/SB/08 (2-92)  
Sheet 1 of 1

Form PTO-1449  INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (Use several sheets if necessary)	Docket Number: <b>449122024200</b>	Application Number: <b>New U.S. Application</b>
	Applicant <b>Michael DIEHL</b>	
	Filing Date: <b>March 14, 2002</b>	Group Art Unit: <b>Not yet assigned</b>

## U.S. PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Name	Class	Subclass	Filing Date If Appropriate
<i>CEL</i>	1.	5/1998	4,745,540	Hamada et al.			

## FOREIGN PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Country	Class	Subclass	Translation YES NO	
	2.	8/1998	WO 98/35275	WIPO			X	
							(Abstract)	
	3.	3/1999	DE 197 34 694 A1	GERMANY				X
	4.	2/1998	DE 196 29 868 A1	GERMANY				X
	5.	2/1997	DE 195 29 718 A1	GERMANY				X

## OTHER DOCUMENTS

(including author, title, Date, Pertinent Pages, Etc.)

Examiner Initials	Ref. No.	Title

EXAMINER: (examiner) *Christopher S. Lee*DATE CONSIDERED: *8/10/04*

EXAMINER: Initial if citation considered, whether or not the citation conforms with MPEP 609. Draw a line through the citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

Form PTO-1449  <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>	Docket Number: <b>449122024200</b>	Application Number: <b>10/070,991</b>
	Applicant <b>Michael DIEHL</b>	
	Filing Date: <b>March 14, 2002</b>	Group Art Unit: <b>2181</b>

## U.S. PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Name	Class	Subclass	Filing Date If Appropriate

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	1.	3/1999	DE 197 34 694 A1	GERMANY			X (Abstract)	
	2.	2/1998	DE 196 29 868 A1	GERMANY			X (Abstract)	
<i>CB</i>	3.	2/1997	DE 195 29 718 A1	GERMANY			(U.S. 5,927,218)	

## OTHER DOCUMENTS

*(including author, title, Date, Pertinent Pages, Etc.)*

Examiner Initials	Ref. No.	Title

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EXAMINER: (examiner)

*Christopher E. Lee*

DATE CONSIDERED:

*8/10/04*

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